

32-Channel, 24-Bit Current-to-Digital ADC

Data Sheet ADAS1126

FEATURES

32-channel, low level current-to-digital converter Up to 24-bit resolution

Up to 19.7 kSPS (50.7 µs integration time)

Simultaneous sampling

Ultralow noise (down to 0.4 fC [2500e-])

User-adjustable full-scale range

INL: ±0.025% of reading ±0.75 ppm of FSR

Very low power dissipation: 12.5 mW/channel

LVDS self-clocked serial data interface

SPI configuration registers (daisy-chain)

On-board temperature sensor and reference buffer

10 mm × 10 mm, mini-BGA package

Low cost external components

Support tools

Evaluation board

Reference design with reference layout

FPGA Verilog code

APPLICATIONS

Medical, industrial, and security CT scanner data acquisition

Photodiode sensors

Dosimetry and radiation therapy systems

Optical fiber power monitoring

X-ray detection systems

High channel-count data acquisition systems (current or

voltage inputs)

GENERAL DESCRIPTION

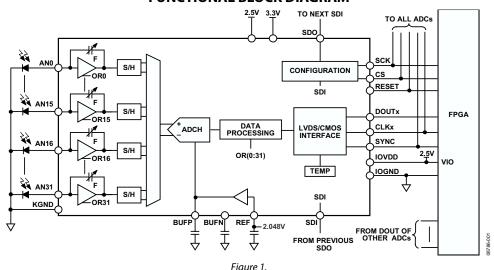
The ADAS1126 is a 32-channel, current-to-digital, analog-todigital converter (ADC). It contains 32 low power, low noise, low input current integrators, simultaneous sample-and-holds, and a high speed, high resolution ADCs with configurable sampling rate and resolutions up to 24 bits.

All converted channel results are output on a single LVDS selfclocked serial interface, which reduces external hardware.

An SPI-compatible serial interface allows configuration of the ADC using the SDI input. The SDO output allows the user to daisy-chain several ADCs on a single, 3-wire bus. The ADAS1126 uses the separate supply IOVDD to reduce the digital noise effect on the conversions.

The ADAS1126 is in a 10 mm \times 10 mm, mini-BGA package.

FUNCTIONAL BLOCK DIAGRAM



For more information about the ADAS1126, email: adas@analog.com.

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NOTES

